FAIRCHILD SEMICONDUCTOR™

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DM74ALS165
8-Bit Parallel In/Serial Out Shift Register

General Description

The DM74ALS165 is an 8-bit serial register that, when clocked, shifts the data toward serial output, $\overline{Q}_H$. Parallel-in access to each stage is provided by eight individual direct data inputs that are enabled by a low level at the SH/$\overline{LD}$ input. The DM74ALS165 also features a clock inhibit function and a complemented serial output, $\overline{Q}_H$.

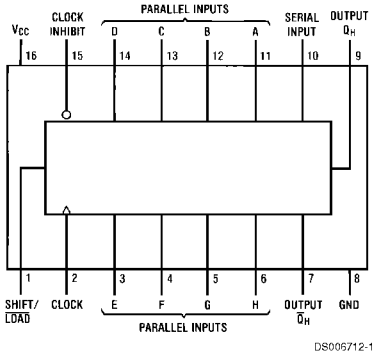
Clocking is accomplished by a low-to-high transition of the CLK input while SH/$\overline{LD}$ is held high and CLK INH is held low. The functions of the CLK and CLK INH (clock inhibit) inputs are interchangeable. Since a low CLK input and a low-to-high transition of CLK INH will also accomplish clocking, CLK INH should be changed to the high level only while the CLK input is high. Parallel loading is inhibited when SH/$\overline{LD}$ is held high. The parallel inputs to the register are enabled while SH/$\overline{LD}$ is low independently of the levels of CLK, CLK INH, or SER inputs.

Features

- Complementary outputs
- Direct overriding load (data) inputs
- Gated clock inputs
- Parallel-to-serial data conversion

Connection Diagram

Dual-In-Line Package



Order Number DM74ALS165M or DM74ALS165N
See Package Number M16A or N16A

Function Table

Inputs					Internal Outputs		Output
Shift/ Load	Clock Inhibit	Clock	Serial	Parallel A...H	Q_A	Q_B	Q_H
L	X	X	X	a...h	a	b	h
H	L	L	X	X	Q_{A0}	Q_{B0}	Q_{H0}
H	L	↑	H	X	H	Q_{An}	Q_{Gn}
H	L	↑	L	X	L	Q_{An}	Q_{Gn}
H	↑	L	H	X	H	Q_{An}	Q_{Gn}
H	↑	L	L	X	L	Q_{An}	Q_{Gn}
H	H	X	X	X	Q_{A0}	Q_{B0}	Q_{H0}

H = High Level (steady-state), L = Low Level (steady-state)
X = Don't Care (any input, including transitions)
↑ = Transition from low-to-high level
a...h = The level of steady-state input at inputs A through H, respectively
Q_{A0}, Q_{B0}, Q_{H0} = The level of Q_A, Q_B, or Q_H, respectively, before the indicated steady-state input conditions were established
Q_{An}, Q_{Gn} = The level of Q_A or Q_G, respectively, before the most recent ↑ transition of the clock

Absolute Maximum Ratings (Note 1)

Supply Voltage	7V
Input Voltage	7V
Operating Free Air Temperature Range	
DM74ALS	0°C to +70°C
Storage Temperature Range	−65°C to +150°C
Typical θ_{JA}	
N Package	74.0°C/W
M Package	104.0°C/W

Recommended Operating Conditions

Symbol	Parameter		DM74ALS165			Units
			Min	Typ	Max	
V_{CC}	Supply Voltage		4.5	5	5.5	V
V_{IH}	High Level Input Voltage		2			V
V_{IL}	Low Level Input Voltage				0.8	V
I_{OH}	High Level Output Current				−0.4	mA
I_{OL}	Low Level Output Current				8	mA
f_{CLOCK}	Clock Frequency		45			MHz
t_W	Pulse Duration	CLK High	11			ns
		CLK Low	11			
		Load	12			
t_{SU}	Setup Time	SH/$\overline{LD}$	10			ns
		Data	10			
t_{SU}	Setup Time	CLK INH ↓ before CLK	11			ns
		Serial before CLK	10			
t_H	Hold Time		4			ns
T_A	Operating Free Air Temperature		0		70	°C

Note 1: *The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the "Electrical Characteristics" table are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.*

Electrical Characteristics

over recommended operating free air temperature range (unless otherwise noted)

Symbol	Parameter	Conditions		DM74ALS165			Units
				Min	Typ (Note 2)	Max	
V_{IK}	Input Clamp Voltage	V_{CC} = 4.5V, I_I = −18 mA				−1.5	V
V_{OH}	High Level Output Voltage	I_{OH} = −0.4 mA, V_{CC} = 4.5V to 5.5V		V_{CC} − 2			V
V_{OL}	Low Level Output Voltage	V_{CC} = 4.5V	I_{OL} = 4 mA		0.25	0.4	V
			I_{OL} = 8 mA		0.35	0.5	
I_I	Input Current at Max Input Voltage	V_{CC} = 5.5V, V_I = 7V				0.1	mA
I_{IH}	High Level Input Current	V_{CC} = 5.5V, V_I = 2.7V				20	μA
I_{IL}	Low Level Input Current	V_{CC} = 5.5V, V_I = 0.4V				−0.1	mA
I_O (Note 3)	Output Drive Current	V_{CC} = 5.5V, V_O = 2.25V		−30		−112	mA
I_{CC}	Supply Current	V_{CC} = 5.5V (Note 4)			16	24	mA

Switching Characteristics

over recommended free air temperature range (Note 5) . All typical values are measured at V_{CC} = 5V, T_A = 25°C.

Symbol	Parameter	Input	Output	Conditions	DM74ALS165			Units
					Min	Typ	Max	
f_{MAX}	Maximum Frequency			V_{CC} = 4.5V to 5.5V,	45	60		MHz
t_{PLH}	Propagation Delay Time Low to High Level Output	Load	Q_H or $\overline{Q}_H$	C_L = 50 pF, R_L = 500Ω	4	13	20	ns
t_{PHL}	Propagation Delay Time High to Low Level Output	Load	Q_H or $\overline{Q}_H$	T_A = Min to Max	4	14	22	
t_{PLH}	Propagation Delay Time Low to High Level Output	CLK	Q_H or $\overline{Q}_H$		3	7	13	ns
t_{PHL}	Propagation Delay Time High to Low Level Output	CLK	Q_H or $\overline{Q}_H$		3	9	14	
t_{PLH}	Propagation Delay Time Low to High Level Output	H	Q_H		3	7	13	ns
t_{PHL}	Propagation Delay Time High to Low Level Output	H	Q_H		3	9	16	
t_{PLH}	Propagation Delay Time Low to High Level Output	H	$\overline{Q}_H$		2	8	15	ns
t_{PHL}	Propagation Delay Time High to Low Level Output	H	$\overline{Q}_H$		3	9	16	

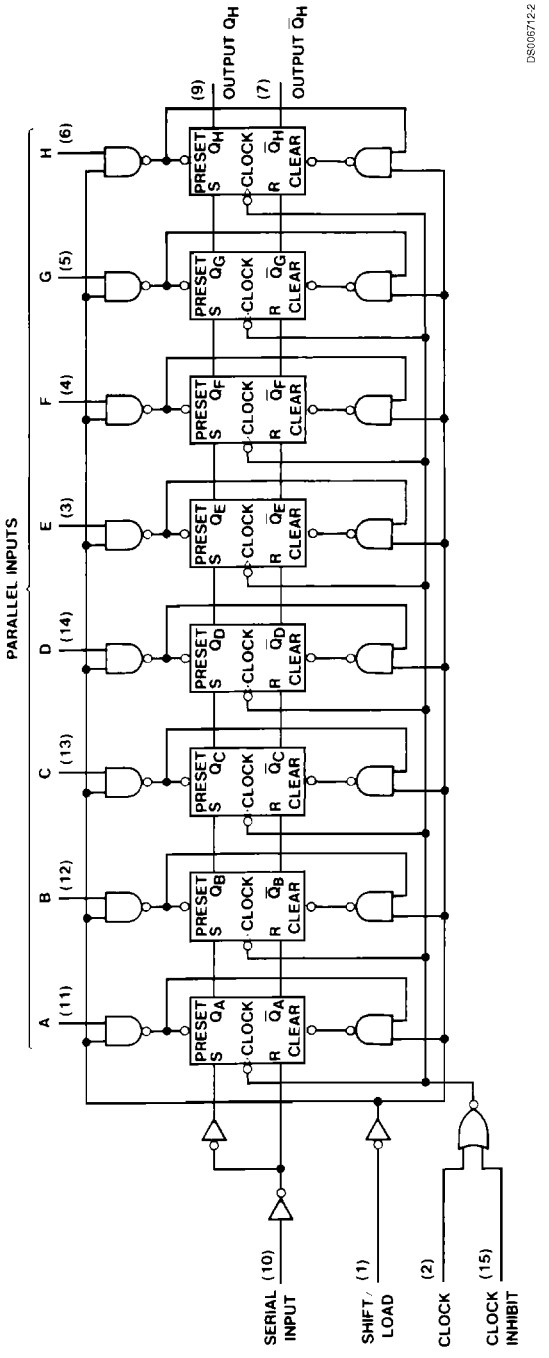
Note 2: All typical values are at V_{CC} = 5V, T_A = 25°C.

Note 3: The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS}.

Note 4: With the outputs open, CLK INH and CLK at 4.5V, and a clock pulse applied to the SH/$\overline{LD}$ input, I_{CC} is measured first with the parallel inputs at 4.5V, then with the parallel inputs grounded.

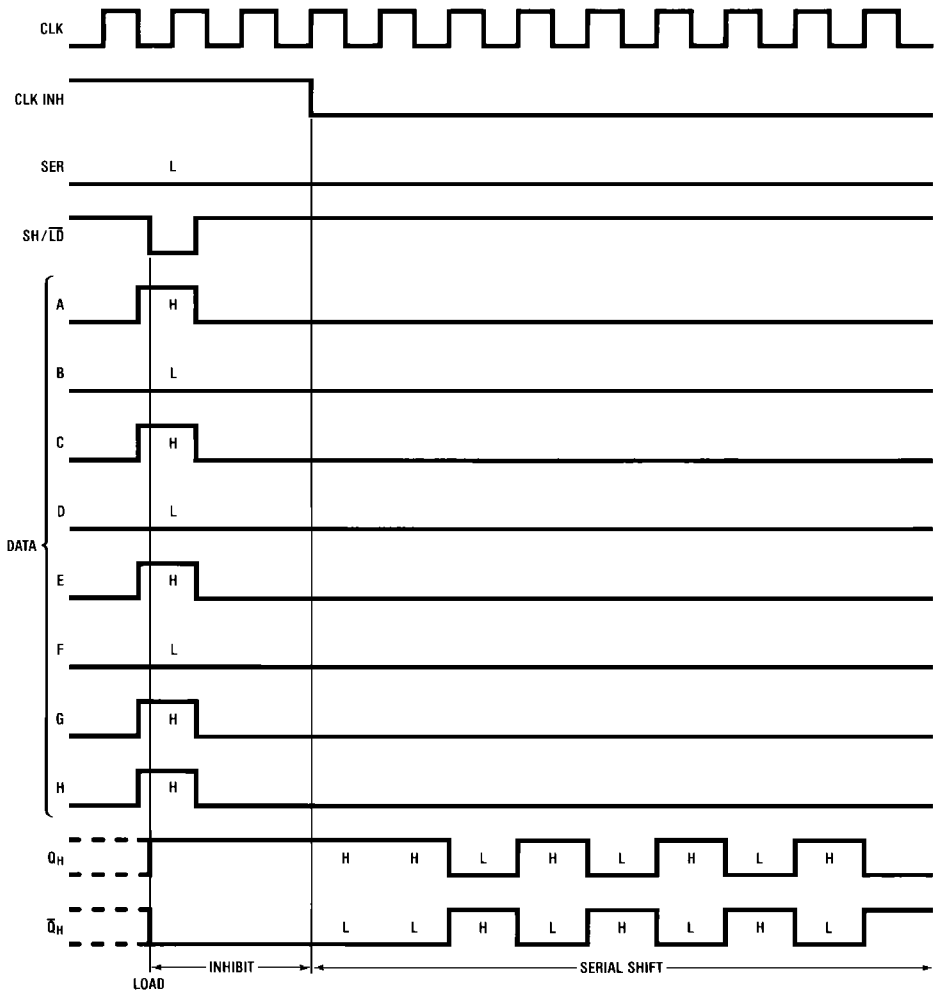
Note 5: See Section 1 for test waveforms and output load.

Logic Diagram

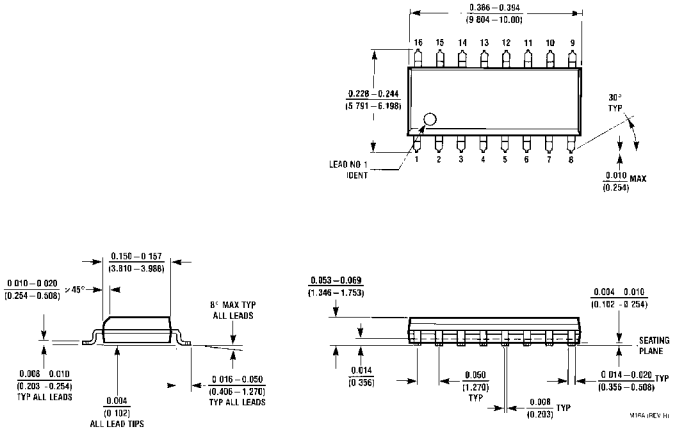


Timing Diagram

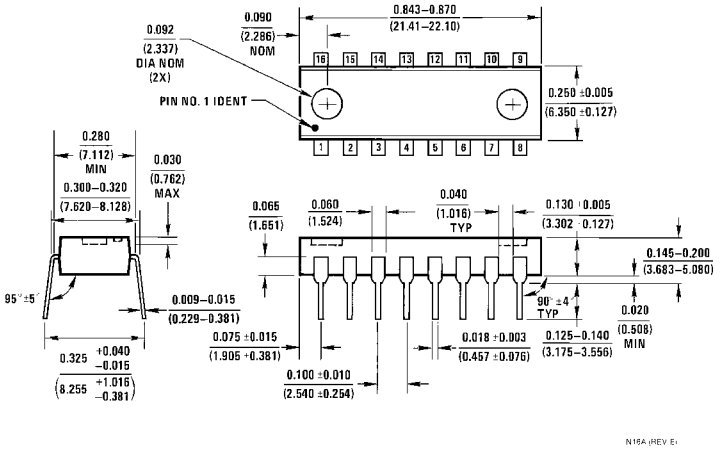
Typical Shift, Load, and Inhibit Sequences



Physical Dimensions inches (millimeters) unless otherwise noted



Small Outline Package (M)
Order Number DM74ALS165M
Package Number M16A



Molded Dual-In-Line Package (N)
Order Number DM74ALS165N
Package Number N16A

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Fairchild Semiconductor Corporation
Americas
Customer Response Center
Tel: 1-888-522-5372

www.fairchildsemi.com

Fairchild Semiconductor Europe
Fax: +49 (0) 1 80-530 85 86
Email: europe.support@nsc.com
Deutsch Tel: +49 (0) 8 141-35-0
English Tel: +44 (0) 1 793-85-68-56
Italy Tel: +39 (0) 2 57 5631

Fairchild Semiconductor Hong Kong Ltd.
13th Floor, Straight Block,
Ocean Centre, 5 Canton Rd.
Tsimshatsui, Kowloon
Hong Kong
Tel: +852 2737-7200
Fax: +852 2314-0061

National Semiconductor Japan Ltd.
Tel: 81-3-5620-6175
Fax: 81-3-5620-6179